

Search Notes



Application/Control No.

10/825,781

Examiner

Henry K. Choe

Applicant(s)/Patent under Reexamination

CHIEN ET AL.

Art Unit

2817

SEARCHED

| Class | Subclass | Date | Examiner |
|-----------------------------|----------|--------|----------|
| 330 | ~59 | 3/1/06 | |
| " | ~58 | " | |
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| " | ~52 | 3/2/06 | |
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| up into search 9/21/06 H.C. | | | |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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| Searched above 9/23/06 H.C. | | | |
| See attachment | | | |
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)

| | DATE | EXMR |
|------------------------------------|-------------|------|
| Trh sh (East) see attachment | 3/2/06 H.C. | |
| NPL (IEEE) see attachment | " | " |
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